

FQD6N50C / FQU6N50C

N-Channel QFET MOSFET

500 V, 4.5 A, 1.2 Ω

Description

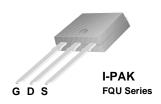
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

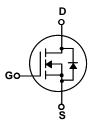


Features

- 4.5 A, 500 V, $R_{DS(on)}$ = 1.2 Ω (Max) @V_{GS} = 10 V, I_D = 2.25 A
- Low Gate Charge (Typ. 19 nC)
- Low Crss (Typ. 15 pF)
- · 100% Avalanche Tested







Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQD6N50C / FQU6N50C	Unit
V_{DSS}	Drain-Source Voltage		500	V
I _D	Drain Current - Continuous (T _C = 25°C)		4.5	Α
	- Continuous (T _C = 100°C)		2.7	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	18	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	300	mJ
I _{AR}	Avalanche Current	(Note 1)	4.5	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	6.1	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
	Power Dissipation (T _A = 25°C)*		2.5	W
P_{D}	Power Dissipation (T _C = 25°C)		61	W
	- Derate above 25°C		0.49	W/°C
T_J,T_STG	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	2.05	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	-	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	-	110	°C/W
When mounted on the minimum pad size recommended (PCB Mount)				

	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$				V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.8		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V		-	1	μΑ
		V _{DS} = 400 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 2.25A		1.0	1.2	Ω
g _{FS}	Forward Transconductance	$V_{DS} = 40 \text{ V}, I_D = 2.25 \text{A}$ (Note 4)		4.5		S
C _{oss} C _{rss}	Output Capacitance Reverse Transfer Capacitance	f = 1.0 MHz		80 15	105	pF
C _{rss}	Reverse Transfer Capacitance			15		
			1	10	20	pF
Switch	ing Characteristics			10	20	pF
	ing Characteristics Turn-On Delay Time	V _{DD} = 250 V, I _D = 4.5A.		10	30	pF ns
Switch t _{d(on)} t _r	<u> </u>	$V_{DD} = 250 \text{ V}, I_{D} = 4.5\text{A},$ $R_{G} = 25 \Omega$			I	
t _{d(on)}	Turn-On Delay Time	$R_G = 25 \Omega$		10	30	ns
$t_{d(on)}$ t_r $t_{d(off)}$	Turn-On Delay Time Turn-On Rise Time			10 35	30 80	ns ns
$t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$R_G = 25 \Omega$		10 35 55	30 80 120	ns ns ns
$t_{d(on)}$ t_r $t_{d(off)}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	$R_G = 25 \Omega$ (Note 4, 5)		10 35 55 45	30 80 120 100	ns ns ns
$t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 400 \text{ V}, I_D = 4.5\text{A},$		10 35 55 45 19	30 80 120 100 25	ns ns ns ns
$t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_{gs} Q_{gd}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 400 \text{ V}, I_D = 4.5\text{A}, V_{GS} = 10 \text{ V}$ (Note 4, 5)		10 35 55 45 19 2.8	30 80 120 100 25	ns ns ns ns
$t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_{gs} Q_{gd}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_G = 25 \ \Omega$ (Note 4, 5) $V_{DS} = 400 \ V, I_D = 4.5 A,$ $V_{GS} = 10 \ V$ (Note 4, 5) $N_{CS} = 10 \ V$ (Note 4, 5)		10 35 55 45 19 2.8	30 80 120 100 25	ns ns ns ns
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd} Drain-\$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 400 \text{ V}, I_D = 4.5\text{A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) and Maximum Ratings of the Forward Current	 	10 35 55 45 19 2.8 8.8	30 80 120 100 25 	ns ns ns ns nC nC
$egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ egin{array}{c} Q_{gd} \\ \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics and Maximum Continuous Drain-Source Diode	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 400 \text{ V}, I_D = 4.5\text{A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) and Maximum Ratings of the Forward Current		10 35 55 45 19 2.8 8.8	30 80 120 100 25 	ns ns ns ns nC nC
$egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \hline egin{array}{c} Drain-S \\ I_{SM} \\ \hline \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics ar Maximum Continuous Drain-Source Diode F	$R_G = 25 \Omega$ (Note 4, 5) $V_{DS} = 400 \text{ V}, I_D = 4.5\text{A},$ $V_{GS} = 10 \text{ V}$ (Note 4, 5) and Maximum Ratings the Forward Current Forward Current		10 35 55 45 19 2.8 8.8	30 80 120 100 25 4.5	ns ns ns nc nC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 26.6 mH, I_{AS} = 4.5A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. I_{SD} ≤ 4.5A, di/dt ≤ 200A/ μ s, V_{DD} ≤ BV $_{DSS}$, Starting T_{J} = 25°C 4. Pulse Test : Pulse width ≤ 300 μ s, Duty cycle ≤ 2% 5. Essentially independent of operating temperature

Typical Characteristics

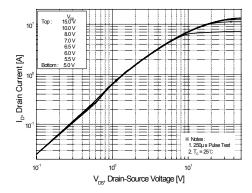


Figure 1. On-Region Characteristics

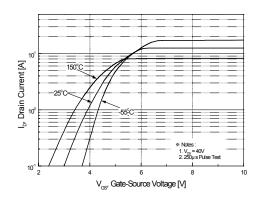


Figure 2. Transfer Characteristics

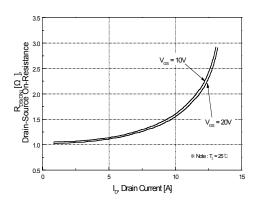


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

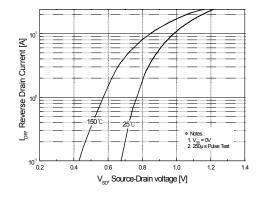


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

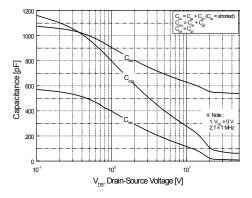


Figure 5. Capacitance Characteristics

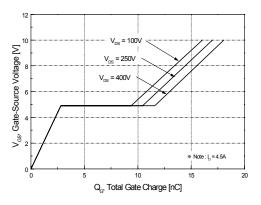


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

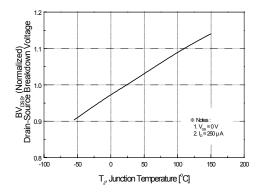


Figure 7. Breakdown Voltage Variation vs Temperature

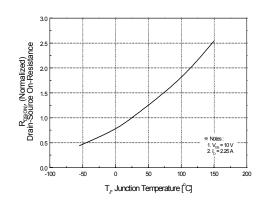


Figure 8. On-Resistance Variation vs Temperature

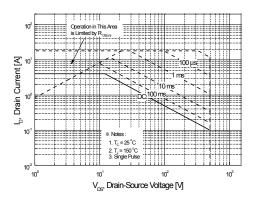


Figure 9. Maximum Safe Operating Area

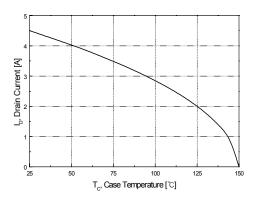


Figure 10. Maximum Drain Current vs Case Temperature

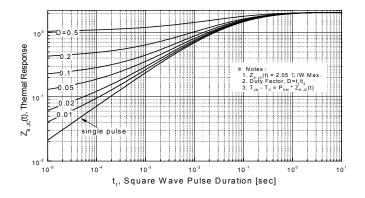
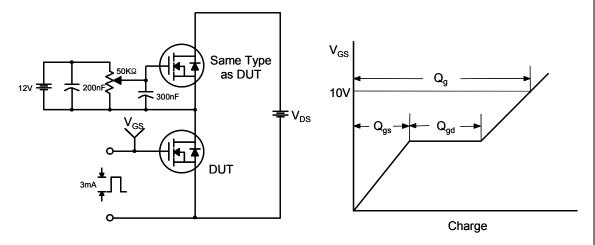
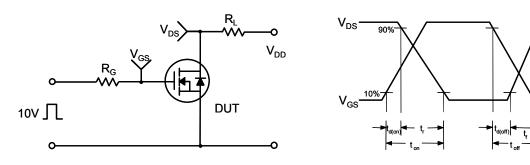


Figure 11. Transient Thermal Response Curve

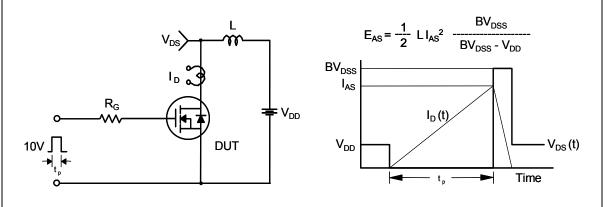
Gate Charge Test Circuit & Waveform



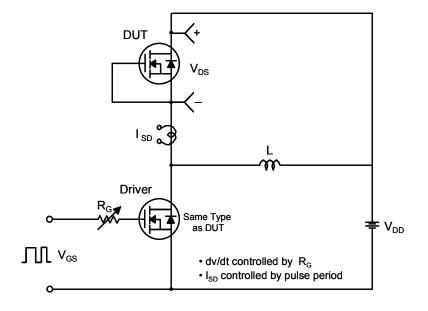
Resistive Switching Test Circuit & Waveforms

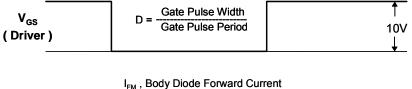


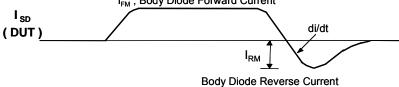
Unclamped Inductive Switching Test Circuit & Waveforms

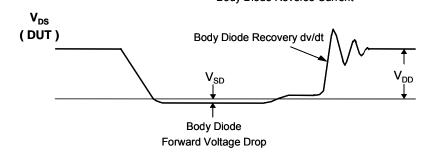


Peak Diode Recovery dv/dt Test Circuit & Waveforms



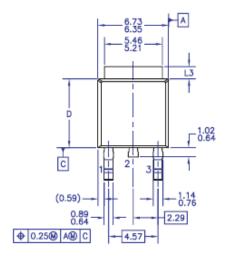


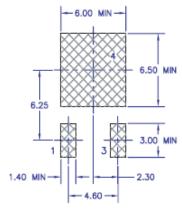


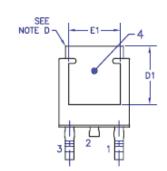


Mechanical Dimensions

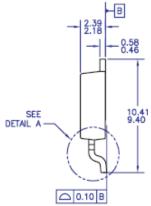
D - PAK

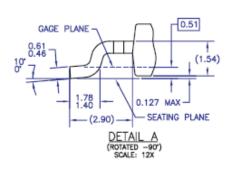








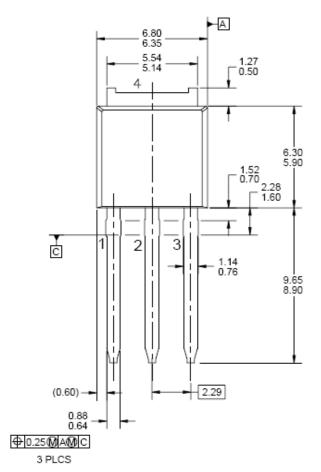


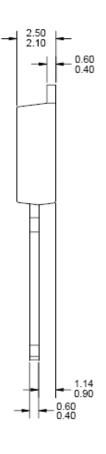


Dimensions in Millimeters

Mechanical Dimensions

I - PAK







Dimensions in Millimeters





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